

**Search Notes**

Application/Control No.

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Examiner

Benny Q. Tieu

Applicant(s)/Patent under  
Reexamination

MADOCH ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	219 220.01 221.01 221.08- 221.1	7/9/2005	BQT
	221.15		
	229 230		
	207.02		
Updated	Search	12/12/2005	BQT
Updated	Search	4/22/2006	BQT

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/9/2005	BQT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner